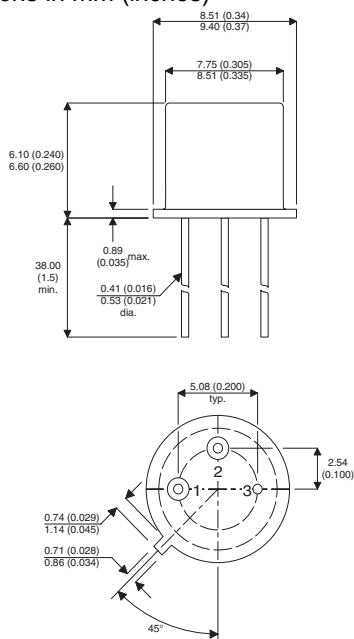


## MECHANICAL DATA

Dimensions in mm (inches)



## TO5 (TO-205AA)

Underside View

PIN 1 – Emitter

PIN 2 – Base

PIN 3 – Collector

## HIGH VOLTAGE SILICON EPITAXIAL NPN TRANSISTOR

### FEATURES

- SILICON PLANAR EPITAXIAL NPN TRANSISTOR
- HIGH BREAKDOWN VOLTAGE
- LOW SATURATION VOLTAGE
- HERMETIC TO5 or TO39 ('S' Suffix) PACKAGE
- HI-RELIABILITY SCREENING OPTIONS AVAILABLE

### APPLICATIONS

For high reliability general purpose high voltage switching and linear applications requiring small size and low weight devices.

## ABSOLUTE MAXIMUM RATINGS $T_{CASE} = 25^{\circ}C$ unless otherwise stated

$V_{CBO}$	Collector - Base Voltage	1000V
$V_{CER}$	Collector - Emitter Voltage ( $R_{BE} = 1.0K\Omega$ )	1000V
$V_{EBO}$	Emitter - Base Voltage	5V
$I_C$	Continuous Collector Current	0.5A
$P_{tot}$	Total Power Dissipation $T_{case} = 50^{\circ}C$	2W
	De-rate Linearly $T_{case} > 25^{\circ}C$	20mW/ $^{\circ}C$
$T_{stg}, T_J$	Operating and Storage Temperature Range	-55 to +150 $^{\circ}C$

Semelab Plc reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by Semelab is believed to be both accurate and reliable at the time of going to press. However Semelab assumes no responsibility for any errors or omissions discovered in its use. Semelab encourages customers to verify that datasheets are current before placing orders.

## THERMAL CHARACTERISTICS

$R_{\theta JC}$	Thermal Resistance Junction - Case	Max	50	°C/W
$R_{\theta JA}$	Thermal Resistance Junction - Ambient	Max	175	°C/W

## ELECTRICAL CHARACTERISTICS ( $T_{case}=25^{\circ}\text{C}$ unless otherwise stated)

	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{(BR)CER}^*$	Collector - Emitter Breakdown Voltage	$I_C = 100\mu\text{A}$ $R_{BE} = 1.0\text{K}\Omega$	1000	-	-	V
$V_{(BR)CBO}^*$	Collector - Base Breakdown Voltage	$I_C = 200\mu\text{A}$	1000	-	-	
$V_{(BR)EBO}^*$	Emitter - Base Breakdown Voltage	$I_C = 0$ $I_E = 50\mu\text{A}$	5.0	-	-	
$I_{CBO}^*$	Collector - Base Cut-Off Current	$V_{CB} = 760\text{V}$	-	-	12	$\mu\text{A}$
		$T_{CASE} = 100^{\circ}\text{C}$	-	10	100	
$I_{EBO}^*$	Emitter - Base Cut-Off Current	$V_{EB} = 4\text{V}$	-	-	20	V
$V_{CE(sat)}^*$	Collector - Emitter Saturation Voltage	$I_C = 20\text{mA}$ $I_B = 5.0\text{mA}$	-	-	1.8	V
$V_{BE(sat)}^*$	Base - Emitter Saturation Voltage	$I_C = 20\text{mA}$ $I_B = 5.0\text{mA}$	-	-	1.0	V
$h_{FE}^*$	DC Current Gain	$I_C = 5\text{mA}$ $V_{CE} = 10\text{V}$	10	-	-	
		$I_C = 20\text{mA}$ $V_{CE} = 10\text{V}$	30	-	180	
		$T_{CASE} = -55^{\circ}\text{C}$	10	-	-	

## DYNAMIC CHARACTERISTICS ( $T_{case}=25^{\circ}\text{C}$ unless otherwise stated)

$f_T$	Transition Frequency	$I_C = 20\text{mA}$ $V_{CE} = 10\text{V}$ $f = 10\text{MHz}$	10	-	-	MHz
$C_{OBO}$	Open Circuit Output Capacitance	$I_E = 0$ $V_{CB} = 10\text{V}$ $f = 1.0\text{MHz}$	-	-	30	pF

\* Pulse test  $t_p = 300\mu\text{s}$ ,  $\delta < 2\%$

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